

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 1 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,422,960 A	12-1983	Shiroto et al.	502/206
*	B	US-4,424,176 A	01-1984	Shirley et al.	264/7
*	C	US-4,444,655 A	04-1984	Shiroto et al.	208/210
*	D	US-5,689,024 A	11-1997	Schmitt, Kirk D.	585/467
*	E	US-6,103,215 A	08-2000	Zones et al.	423/702
*	F	US-6,168,709 B1	01-2001	Etter, Roger G.	208/131
*	G	US-2001/0000743 A1	05-2001	Yuasa et al.	430/110
*	H	US-2001/0002305 A1	05-2001	Yuasa et al.	430/110
*	I	US-6,270,937 B1	08-2001	Yuasa et al.	430/108.7
*	J	US-6,326,116 B1	12-2001	Yuasa et al.	430/110.1
*	K	US-2002/0016503 A1	02-2002	Leiber et al.	562/531
*	L	US-6,417,133 B1	07-2002	Ebner et al.	502/185
*	M	US-2002/0086229 A1	07-2002	Yuasa et al.	430/108.4

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 57032726 A	02-1982	Japan	NAGAHAMA et al.	B01J 02/16
	O	GB 2183670 A	06-1987	United Kingdom	RAMOS et al.	C10K 03/00
	P	DE 3935952 A1	03-1991	Germany	WEIERGRAEBER, PETER	B01D 41/02
	Q	DE 3935953 A1	03-1991	Germany	WEIERGRAEBER, PETER	B01D 41/02
	R	EP 1043051 A2	10-2000	European Patent	FLECK, UTE	B01D 15/00
	S	JP 2001187753 A	07-2001	Japan	IDE et al.	C07C 27/00
	T	JP 2008193971 A	08-2008	Japan	MORIMOTO et al.	

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 2 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,432,599 B1	08-2002	Yuasa et al.	430/108.4
*	B	US-2002/0179493 A1	12-2002	Etter, Roger G.	208/131
*	C	US-2002/0183198 A1	12-2002	Gaffney et al.	502/215
*	D	US-2002/0188149 A1	12-2002	Bogan et al.	558/321
*	E	US-2003/0084693 A1	05-2003	Sower, Larry P.	71/11
*	F	US-2003/0092565 A1	05-2003	Chaudhari et al.	502/150
*	G	US-6,586,621 B2	07-2003	Leiber et al.	562/17
*	H	US-6,603,039 B1	08-2003	Ebner et al.	562/17
*	I	US-2003/0157247 A1	08-2003	Chikami et al.	427/212
*	J	US-2003/0171611 A1	09-2003	Leiber, Mark A.	562/17
*	K	US-2003/0172697 A1	09-2003	Sower, Larry P.	71/11
*	L	US-2003/0190547 A1	10-2003	Kobayashi et al.	430/125
*	M	US-6,645,905 B2	11-2003	Gaffney et al.	502/311

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2942803 A1	09-2010	France	BEHAR, ISAAC	C10G 01/02
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 3 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0229246 A1	12-2003	Leiber et al.	562/17
*	B	US-2004/0010160 A1	01-2004	Coleman et al.	562/17
*	C	US-2004/0029725 A1	02-2004	Gaffney et al.	502/208
*	D	US-2004/0068138 A1	04-2004	Leiber, Mark A.	562/017
*	E	US-6,746,496 B1	06-2004	Kravitz et al.	48/118.5
*	F	US-2004/0181085 A1	09-2004	Bogan et al.	558/323
*	G	US-2004/0235406 A1	11-2004	Duescher, Wayne O.	451/527
*	H	US-6,841,699 B2	01-2005	Bogan et al.	562/547
*	I	US-6,846,343 B2	01-2005	Sower, Larry P.	71/15
*	J	US-2005/0074380 A1	04-2005	Boren et al.	423/001
*	K	US-2005/0176989 A1	08-2005	Coleman et al.	562/011
*	L	US-2005/0176990 A1	08-2005	Coleman et al.	562/011
*	M	US-6,927,304 B2	08-2005	Leiber, Mark A.	562/17

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 4 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,956,005 B2	10-2005	Leiber, Mark A.	502/185
*	B	US-6,963,009 B2	11-2005	Leiber et al.	562/17
*	C	US-2006/0020143 A1	01-2006	Leiber, Mark A.	562/017
*	D	US-2006/0032788 A1	02-2006	Etter, Roger G.	208/131
*	E	US-2006/0068988 A1	03-2006	Coleman et al.	502/182
*	F	US-2006/0069280 A1	03-2006	Gaffney et al.	558/325
*	G	US-7,018,951 B2	03-2006	Gaffney et al.	502/311
*	H	US-7,026,266 B2	04-2006	Chaudhari et al.	502/155
*	I	US-7,045,160 B1	05-2006	de Haan et al.	426/61
*	J	US-7,067,693 B1	06-2006	Ebner et al.	562/17
*	K	US-2006/0229466 A1	10-2006	Arhancet et al.	562/531
*	L	US-7,129,373 B2	10-2006	Coleman et al.	562/17
*	M	US-7,193,107 B2	03-2007	Leiber, Mark A.	562/17

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 5 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0100161 A1	05-2007	Ebner et al.	562/017
*	B	US-2007/0129567 A1	06-2007	Leiber et al.	562/017
*	C	US-7,232,635 B2	06-2007	Kobayashi et al.	430/122.1
*	D	US-2007/0243591 A1	10-2007	Peeters et al.	435/134
*	E	US-7,291,751 B2	11-2007	Leiber et al.	562/17
*	F	US-7,306,780 B1	12-2007	Kravitz et al.	423/648.1
*	G	US-2008/0044337 A1	02-2008	Fallavollita, John Allan	423/349
*	H	US-7,348,292 B2	03-2008	Gaffney et al.	502/311
*	I	US-2008/0103331 A1	05-2008	Gaffney et al.	562/400
*	J	US-7,390,920 B2	06-2008	Coleman et al.	562/17
*	K	US-7,396,955 B2	07-2008	Gaffney et al.	562/400
*	L	US-7,427,302 B1	09-2008	Kravitz et al.	23/300
*	M	US-2008/0318768 A1	12-2008	Coleman et al.	502/177

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 6 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,488,464 B2	02-2009	Hammel et al.	423/592.1
*	B	US-2009/0117635 A1	05-2009	Bradley et al.	435/165
*	C	US-2009/0196848 A1	08-2009	Davis, Richard	424/78.31
*	D	US-7,632,434 B2	12-2009	Duescher, Wayne O.	264/12
*	E	US-2010/0032630 A1	02-2010	HARIHARAN et al.	252/516
*	F	US-2010/0041546 A1	02-2010	Coleman et al.	502/177
*	G	US-7,685,737 B2	03-2010	Gorbell et al.	34/86
*	H	US-2010/0061913 A1	03-2010	HARIHARAN et al.	423/342
*	I	US-2010/0061911 A1	03-2010	HARIHARAN et al.	423/341
*	J	US-2010/0130774 A1	05-2010	Wan et al.	562/17
*	K	US-2010/0136336 A1	06-2010	Borgese et al.	428/402
*	L	US-7,820,126 B2	10-2010	Fallavollita, John Allan	423/349
*	M	US-7,820,418 B2	10-2010	Karl et al.	435/161

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/562,130		Applicant(s)/Patent Under Reexamination BEDETTI, GIANFRANCO	
	Examiner Stephen M. Gravini		Art Unit 3743	Page 7 of 7

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,842,484 B2	11-2010	Lewis, Stephen M.	435/161
*	B	US-7,866,060 B2	01-2011	Carin et al.	34/487
*	C	US-7,882,646 B2	02-2011	Gorbell et al.	34/514
*	D	US-2011/0023778 A1	02-2011	Fallavollita, John Allan	118/666
*	E	US-2011/0027828 A1	02-2011	Peeters et al.	435/41
*	F	US-2011/0059002 A1	03-2011	Fallavollita, John Allan	423/345
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.